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·	Applicati n No.	Applicant(s)
Mada - EAH L-WA	10/054,550	GOODMAN, RODNEY M.
Notice of Allowability	Examiner	Art Unit
	Brian J. Sines	1743
The MAILING DATE of this communication appears on the cover sheet with the correspondence address All claims being allowable, PROSECUTION ON THE MERITS IS (OR REMAINS) CLOSED in this application. If not included herewith (or previously mailed), a Notice of Allowance (PTOL-85) or other appropriate communication will be mailed in due course. THIS NOTICE OF ALLOWABILITY IS NOT A GRANT OF PATENT RIGHTS. This application is subject to withdrawal from issue at the initiative of the Office or upon petition by the applicant. See 37 CFR 1.313 and MPEP 1308.		
 This communication is responsive to <u>the response filed 11/20/2003</u>. 		
2. The allowed claim(s) is/are <u>35-50</u> .		
3. The drawings filed on 18 January 2002 are accepted by the Examiner.		
 4. ☐ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) ☐ All b) ☐ Some* c) ☐ None of the: 		
 ☐ Certified copies of the priority documents have been received. 		
2. Certified copies of the priority documents have been received in Application No		
3. Copies of the certified copies of the priority documents have been received in this national stage application from the		
International Bureau (PCT Rule 17.2(a)).		
* Certified copies not received:		
5. Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application) since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.		
(a) The translation of the foreign language provisional application has been received.		
6. Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121 since a specific reference was included in the first sentence of the specification or in an Application Data Sheet. 37 CFR 1.78.		
Applicant has THREE MONTHS FROM THE "MAILING DATE" of this communication to file a reply complying with the requirements noted below. Failure to timely comply will result in ABANDONMENT of this application. THIS THREE-MONTH PERIOD IS NOT EXTENDABLE		
7. A SUBSTITUTE OATH OR DECLARATION must be submitted. Note the attached EXAMINER'S AMENDMENT or NOTICE OF INFORMAL PATENT APPLICATION (PTO-152) which gives reason(s) why the oath or declaration is deficient.		
 8. ☐ CORRECTED DRAWINGS (as "replacement sheets") must be submitted. (a) ☐ including changes required by the Notice of Draftsperson's Patent Drawing Review (PTO-948) attached 		
1) hereto or 2) to Paper No		
(b) ☐ including changes required by the proposed drawing correction filed, which has been approved by the Examiner.		
(c) I including changes required by the attached Examiner's Amendment / Comment or in the Office action of Paper No		
Identifying indicia such as the application number (see 37 CFR 1.84(c)) should be written on the drawings in the front (not the back) of each sheet. Replacement sheet(s) should be labeled as such in the margin according to 37 CFR 1.121(d).		
9. DEPOSIT OF and/or INFORMATION about the deposit of BIOLOGICAL MATERIAL must be submitted. Note the attached Examiner's comment regarding REQUIREMENT FOR THE DEPOSIT OF BIOLOGICAL MATERIAL.		
Attachment(s)		
1 Notice of References Cited (PTO-892)	5⊡ Notice of Informal Pa	tent Application (PTO-152)
2 Notice of Draftperson's Patent Drawing Review (PTO-948)	• •	PTO-413), Paper No
3 Information Disclosure Statements (PTO-1449 or PTO/SB/08 Paper No	B), 7☐ Examiner's Amendme	ent/Comment
4 Examiner's Comment Regarding Requirement for Deposit	8⊠ Examiner's Statemen	nt of Reasons for Allowance
of Biological Material	9☐ Other .	
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DETAILED ACTION

Allowable Subject Matter

Claims 35 - 50 are allowed.

The following is an examiner's statement of reasons for allowance:

Lewis *et al.* (U.S. Pat. No. 5,571, 401 A) teach an analyte detection system having a sensor array comprising a plurality of sensor sites, wherein the sensor array comprises: a first sensor site comprising a first material having regions of a nonconductive organic polymer material, such as main-chain carbon polymers including poly(dienes), and a conductive material, such as polypyrrole, and a second sensor site comprising a second material having regions of a nonconductive organic polymer material and a conductive material, wherein an electrical property in each of the sensor sites changes in the presence of an analyte. Lewis et al. do teach that the sensor arrays are particularly well-suited to scaled-up production and may be fabricated using integrated circuit design technologies (see col. 6, lines 47 – 56). Butler (U.S. Pat. No. 4,062,750) teaches a method for forming a sensor on a substrate, which is based upon integrated circuit thin film techniques (see col. 16, lines 49 – 68; col.17, lines 1 – 68; col. 18, lines 1 – 68; figures 9a, 9b, 9c & 10).

The cited prior art neither teach or fairly suggest a method of forming an analyte detection sensor on a substrate, wherein the method comprises the steps of: forming a first conductive layer over the substrate; forming a first insulating layer over the first conductive layer; patterning and etching a sensor well in the first conductive layer and in the first insulating layer; and forming a sensor material in the sensor well, wherein the sensor material has an

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electrical property that changes in the presence of an analyte, wherein the first insulating layer is not removed during the formation of the sensor.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Brian J. Sines whose telephone number is (703) 305-0401. The examiner can normally be reached on Monday - Friday (11:30 AM - 8 PM EST).

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Jill A. Warden can be reached on (703) 308-4037. The fax phone number for the organization where this application or proceeding is assigned is (703) 872-9310.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-0661.

Jill Warden
Supervisory Patent Examiner
Technology Center 1700